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**ATTY. DOCKET NO.**

11281-024-999

**APPLICATION NO.**

10/786,821

**APPLICANT**

Young-Sun Kim et al.

**FILING DATE**

February 25, 2004

**ART UNIT**

2874

**U.S. PATENT DOCUMENTS**

*Examiner Initials		Document Number	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/GU	A03	US 5,103,304	04/07/92	Stanley P. Turcheck	
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**FOREIGN PATENT DOCUMENTS**

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**NON PATENT LITERATURE DOCUMENTS**

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